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Electronic decoupling of an epitaxial graphene monolayer by gold intercalation

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The application of graphene in electronic devices requires large scale epitaxial growth. The presence of the substrate, however, usually reduces the charge carrier mobility considerably. We show that it is possible to decouple the partially sp^3-hybridized first graphitic layer formed on the Si-terminated face of silicon carbide from the substrate by gold intercalation, leading to a completely sp^2-hybridized graphene layer with improved electronic properties.

Electrons in graphene — sp^2-bonded carbon atoms arranged in a honeycomb lattice — behave like massless Dirac particles and exhibit an extremely high carrier mobility [1]. So far, the only feasible route towards large scale production of graphene is epitaxial growth on a substrate. The presence of the substrate will, however, influence the electronic properties of the graphene layer. To preserve its unique properties it is desirable to decouple the graphene layer from the substrate. Here we present a new approach for the growth of highly decoupled epitaxial graphene on a silicon carbide substrate. By decoupling the strongly interacting, partially sp^3-hybridized first graphitic layer (commonly referred to as zero layer (ZL) [2]) from the SiC(0001) substrate by gold intercalation, we obtain a completely sp^2-hybridized graphene layer with improved electronic properties as confirmed by angle-resolved photoemission spectroscopy (ARPES), scanning tunneling microscopy (STM) and Raman spectroscopy.

There are essentially two ways for large scale epitaxial growth of graphene on a substrate: by cracking organic molecules on catalytic metal surfaces [3–7] or by thermal graphitization of SiC [2, 8–11]. Unfortunately, the presence of the substrate alters the electronic properties of the graphene layer on the surface and reduces the carrier mobility. Even though it has been shown that the graphene layer can be decoupled from a metallic substrate [6, 12–14] the system remains unsuitable for device applications. This problem can be solved by decoupling the graphene layer from a semiconducting SiC substrate [15].

On both the silicon and the carbon terminated face of a SiC substrate, graphene is commonly grown by thermal graphitization in ultra high vacuum (UHV). When annealing the substrate at elevated temperatures Si atoms leave the surface whereas the C atoms remain and form carbon layers. On SiC(000$\overline{1}$), the so-called C-face, the weak graphene-to-substrate interaction results in the growth of rotationally disordered multilayer graphene and a precise thickness control becomes difficult [16]. On the other hand, the rotational disorder decouples the graphene layers so that the transport properties resemble those of isolated graphene sheets with room temperature mobilities in excess of 200,000 cm^2/Vs [17].

On SiC(0001), i. e. the Si-face, the comparatively strong graphene-to-substrate interaction results in uniform, long-range ordered layer-by-layer growth. The first carbon layer (=ZL) grown on the Si-face is partially sp^3-hybridized to the substrate, which means that on a ZL no π-bands can develop and it has no graphene properties. This can be seen in the first panel of Fig. 1 a), where the experimental band structure of the ZL (black) measured by ARPES near the $\overline{\text{K}}$-point of the surface Brillouin zone is shown. The ZL lacks the linear dispersion typical for graphene π-bands. Its band structure consists of two non-dispersing bands at about $-0.3\,$eV and $-1.2\,$eV initial state energy. In addition, the ZL forms a $(6\sqrt{3} \times 6\sqrt{3})$R30° reconstruction with respect to the SiC substrate [2, 16, 18].

Further graphitization leads to the growth of a completely sp^2-hybridized graphene layer, for which the ZL acts as a buffer layer. The band structure of this "conventionally" grown graphene monolayer (cML) near the $\overline{\text{K}}$-point is shown in the second panel of Fig. 1 a). The cML is influenced considerably by the underlying SiC substrate. It is n-doped with the crossing point of the two linear bands (Dirac point) at $E_D = -420\,$meV due to charge transfer from the substrate [8–10, 15]. Furthermore, the possibility of a band gap opening has been suggested [10] and explained theoretically in connection with the formation of midgap states [19]. In addition to that, the strong substrate influence reduces the carrier mobility considerably [20]. The $(6\sqrt{3} \times 6\sqrt{3})$R30° reconstruction of the ZL diffracts the outgoing photoelectrons giving rise to the formation of replica bands [2]. This is nicely seen in the measured Fermi surface of the cML around $\overline{\text{K}}$ in the left panel of Fig. 1 b). The size of the Fermi surface is determined by the charge carrier density $n = k_F^2/\pi$, where k_F is the Fermi wave vector with respect to the $\overline{\text{K}}$-point. The values are summarized in Table I.

To reduce the influence of the substrate we developed a new method for the epitaxial growth of graphene on the Si-face of SiC. We start with the preparation of the ZL exploiting the strong substrate influence for uniform growth. On top of the ZL, we deposit Au atoms at room temperature. After subsequent annealing of the sample at 800°C the linear dispersion typical for graphene appears. Depending on the gold coverage (about one third or one monolayer, respectively), either a strongly n-doped (nML_{Au}) or a p-doped (pML_{Au}) graphene layer is formed. The band structures for the pML_{Au} and the

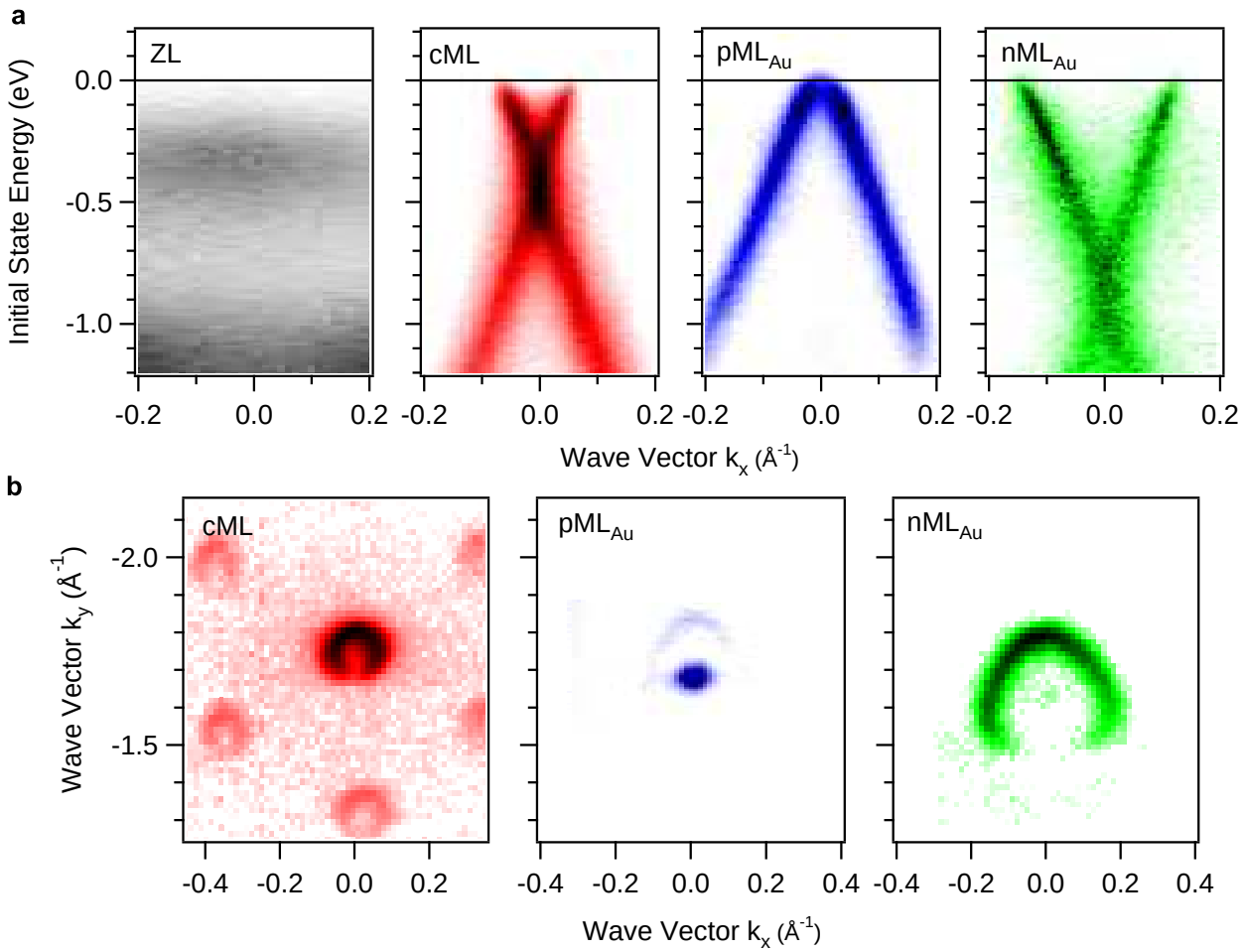

FIG. 1: (color online) Comparison of ARPES data for conventional graphene on SiC and graphene intercalated with Au: panel a) shows the band structure measured in the direction perpendicular to the $\overline{\Gamma K}$ direction near the $\overline{K}$-point of the surface Brillouin zone of the zero layer (black), the conventional graphene monolayer (red), the p-doped graphene monolayer intercalated with gold (blue) and the n-doped graphene monolayer intercalated with gold (green) together with the corresponding Fermi surfaces in panel b). The Fermi surfaces are plotted on a logarithmic color scale to enhance weak features. k_x is perpendicular to the $\overline{\Gamma K}$ direction, k_y is along the $\overline{\Gamma K}$ direction. The Fermi surface for the p-doped graphene monolayer shows a weak contribution of the n-doped phase due to an inhomogeneous Au coverage on the sample.

nML$_{Au}$ are compared in Fig. 1 a). In contrast to the ZL, both the pML$_{Au}$ (blue) and the nML$_{Au}$ (green) clearly show two linearly dispersing π-bands. The Dirac point for the pML$_{Au}$ is about 100 meV above the Fermi level. This band structure looks similar to the one reported in Ref. [21]. However, there the graphene monolayer was prepared by depositing Au directly on a cML and not on a ZL as in this work. For the nML$_{Au}$ the bands cross at about -850 meV. The band structure of the cML is a superposition of the band structure of the underlying ZL and the graphene monolayer. Both pML$_{Au}$ and nML$_{Au}$, however, are formed directly from the ZL. There is no additional carbon layer between the graphene layer and the substrate. Therefore, the band structure around the $\overline{K}$-point is given by the pML$_{Au}$ and nML$_{Au}$ alone. The charge carrier densities deduced from the size of the Fermi surface (see middle and right panel of Fig. 1 b) are listed in Table I.

Comparing the Fermi surfaces for the cML (red), the pML$_{Au}$ (blue), and the nML$_{Au}$ (green) in Fig. 1 b), the most striking difference is the absence of replica bands for the pML$_{Au}$ and nML$_{Au}$. Even on the logarithmic color scale of Fig. 1 b) the replica bands are invisible, indicating a reduced influence of the $(6\sqrt{3} \times 6\sqrt{3})$R30° reconstruction. Low energy electron diffraction (LEED) images (shown in the EPAPS) reveal a strong decrease of the intensity for spots related to the $(6\sqrt{3} \times 6\sqrt{3})$R30° reconstruction for the pML$_{Au}$ as compared to the graphene-related spots. For the nML$_{Au}$, however, the $(6\sqrt{3} \times 6\sqrt{3})$R30° spots have a similar intensity as for the cML. We conclude that only the pML$_{Au}$ is less influenced by the underlying substrate. We attribute this to an increased graphene-to-substrate distance as will be discussed later in this paper.

To analyze the band structure in more detail and gain access to the relevant scattering mechanisms we determined the full width at half maximum (FWHM) of the bands by fitting

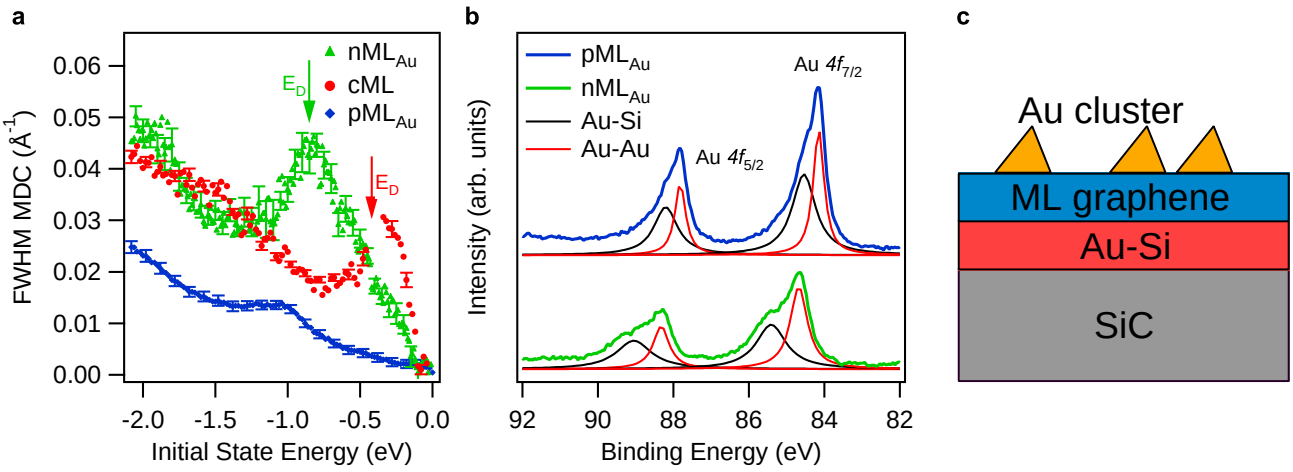

FIG. 2: (color online) Linewidth analysis, Au *4f* core level spectra and schematic: Panel a) shows the full width at half maximum (FWHM) of momentum distribution curves obtained from Fig. 1 a) for the conventional graphene monolayer (red), the p-doped graphene monolayer intercalated with Au (blue) and the n-doped graphene monolayer intercalated with Au (green). A constant background was subtracted from the data so that the plotted linewidth is determined by electron-phonon, electron-plasmon and electron-electron scattering alone. Panel b) shows the Au $4f$ core level spectra recorded with an incident photon energy of 150 eV for the p-doped monolayer (blue) and the n-doped monolayer (green). The core level spectra indicate the presence of Au-Si bonds (black lines) for both the p- and the n-doped monolayer which is consistent with the structural model shown in panel c).

TABLE I: **Characteristic parameters for cML, pML$_{Au}$ and nML$_{Au}$** determined from the photoemission experiments.

	cML	pML$_{Au}$	nML$_{Au}$
Au coverage (ML)	0	1	1/3
Au-Si 4f$_{5/2}$ (eV)		88.20	89.05
Au-Si 4f$_{7/2}$ (eV)		84.54	85.41
Au-Au 4f$_{5/2}$ (eV)		87.82	88.32
Au-Au 4f$_{7/2}$ (eV)		84.15	84.68
charge carrier density (cm^{-2})	1×10^{13} electrons	7×10^{11} holes	5×10^{13} electrons
Dirac point (meV)	-420	$+100$	-850

momentum distribution curves (MDCs) along the $\overline{\Gamma K}$ direction with Lorentzian lineshapes and a constant background. The FWHM as a function of the initial state energy for the cML (red), the pML$_{Au}$ (blue) and the nML$_{Au}$ (green) are shown in Fig. 2 a). From the data in Fig. 2 a) a constant offset of 0.023 Å^{-1} (cML), 0.027 Å^{-1} (pML$_{Au}$), and 0.041 Å^{-1} (nML$_{Au}$) has been subtracted. For both cML and pML$_{Au}$ this offset is mainly determined by the experimental resolution (see EPAPS). For the nML$_{Au}$, however, the linewidth offset is significantly larger than the limit set by the experimental resolution. In this case the offset is determined by impurity scattering which gives a constant contribution to the linewidth at all energies.

There are three main contributions to the quasiparticle lifetime in graphene [2, 8]. The increase in linewidth around 200 meV is caused by electron-phonon coupling which depends on the size of the Fermi surface. Therefore, its influence is largest for strongly n-doped graphene (nML$_{Au}$). The pronounced maximum near the Dirac point is attributed to electron-plasmon scattering. The third contribution to the line width is electron-electron scattering, which has been found to be proportional to $|E - E_F|^\alpha$, where $1 < \alpha < 2$ [8]. The FWHM for our cML is in good agreement with the data reported in Ref. [2, 8]. Also, the cML and the nML$_{Au}$ have a similar linewidth. The main difference between the two is the position of the plasmon peak which is determined by the position of the Dirac point and hence the doping level. The pML$_{Au}$, however, has a much lower linewidth over the whole range of energies indicating a reduced electron-electron scattering. As the Fermi surface for the pML$_{Au}$ is rather small (see Fig. 1 b) the electron-phonon contribution to the linewidth is negligible. The local maximum in linewidth around -1 eV initial state energy for the pML$_{Au}$ is not located at the Dirac point. Therefore, we do not interpret this as originating from plasmons within the graphene layer according to [2, 8]. We tentatively attribute this peak to plasmons localized mainly in the Au clusters on top of the pML$_{Au}$ that interact with the electrons in the graphene layer. Varykhalov et al. [6] found a similar feature for graphene/Au/Ni(111) which they attributed to an interaction between Au and graphene. The overall much smaller linewidth for the pML$_{Au}$ corroborates the conclusion from LEED that the pML$_{Au}$ is decoupled from the substrate. As mentioned before, the measured linewidth for the pML$_{Au}$ near the Fermi level is mainly determined by the experimental momentum resolution of $\Delta k = 0.023$ Å^{-1}. This allows us to estimate a lower limit for the carrier lifetime using $\tau = \hbar/(\hbar v_F \Delta k)$. With $\hbar v_F = 7.06$ eVÅ, we find that $\tau > 4$ fs which is the same order of magnitude as the value

reported for multilayer graphene on the C-face of SiC [17].

To gain a deeper insight into the structure of the pML_{Au} and nML_{Au}, we measured the Au $4f$ core level spectra using a photon energy of 150 eV. The spectra in Fig. 2 b) for the pML_{Au} (blue) and the nML_{Au} (green) show two different contributions to the Au $4f$ core level. The doublet at higher binding energy was attributed to Au-Si bonds before [22, 23]. The doublet at lower binding energy belongs to Au-Au bonds [24]. The peak positions are summarized in Table I.

Combining these observations with the band structures in Fig. 1, we can deduce a schematic as depicted in Fig. 2 c). The appearance of a linear dispersion typical for graphene implies that the C-Si bonds between ZL and substrate break and a completely sp^2-hybridized carbon monolayer is created. The core level spectra show the existence of Au-Si bonds for both the nML_{Au} and the pML_{Au}. We conclude that the Au atoms intercalate between the ZL and the substrate replacing the C-Si bonds by Au-Si bonds. From the core level peak intensity for the nML_{Au}, we find about one third monolayer of Au intercalated (one monolayer corresponds to two Au atoms per graphene unit cell). This is consistent with the observation that every third carbon atom in the ZL forms a C-Si bond [16]. For the pML_{Au}, about one monolayer of gold is intercalated. From atomic force microscopy (AFM - not shown here) and STM measurements, we find that additional Au atoms are not intercalated, but form Au clusters on top of the graphene layer. Despite the fact that a complete monolayer of gold is intercalated for the pML_{Au} the substrate does not become metallic. Apart from the graphene bands, there are no other states visible at the Fermi energy.

The doping behavior for different Au coverages has been addressed by the theoretical work of Giovannetti et al. [25] who predicted p-type doping for graphene on a Au substrate. Reducing the Au-graphene distance to $d_{AuG} < 3.2$ Å, however, will lead to n-type doping. The larger amount of intercalated Au for the pML_{Au} should increase the distance between graphene and substrate. This is consistent with the observed doping behavior as well as the reduced influence of the $(6\sqrt{3} \times 6\sqrt{3})$R30° interface reconstruction on the Fermi surface and the LEED images of the pML_{Au}.

The peak position for the Au $4f$ doublet associated with Au-Si bonds shifts by about 860 meV from nML_{Au} to pML_{Au}. This can be related to the observed difference in the doping and a small change of the work function. The Au-Au component, on the other hand, shifts only by about 520 meV. We attribute the Au-Au bonds to Au clusters on top of the graphene layer. These clusters have an average size of a few nanometers (see Fig. 3 a). For such nanoparticles the position of the core levels depends rather sensitively on the size of the particle [26, 27]. Thus, the shift of the Au-Au component of the Au $4f$ core level is most likely related to the size of the particular Au clusters.

As both LEED and ARPES average over a rather large area on the sample surface, we used STM to gain access to the structure of the surface on an atomic scale. Fig. 3 a) shows topographic images of the cML and the pML_{Au}. The cML

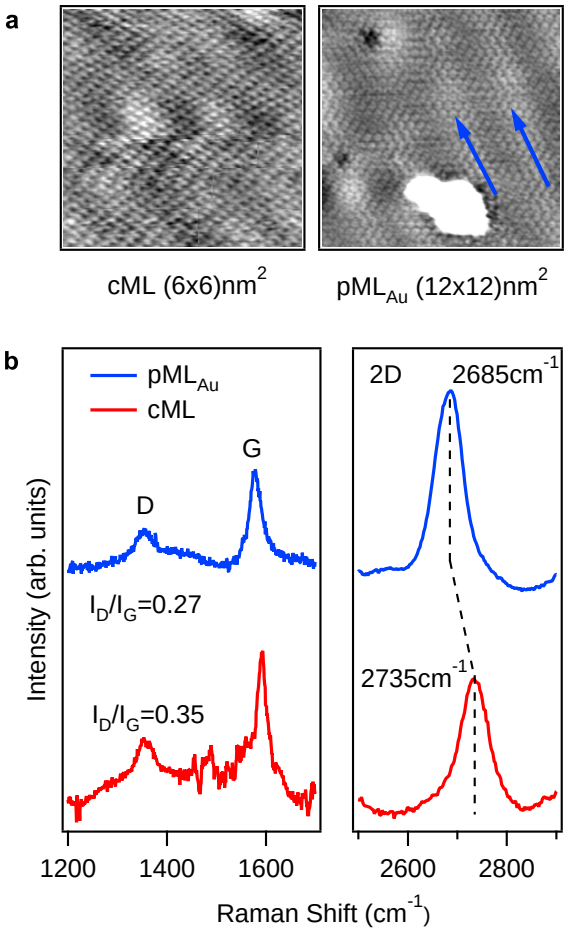

FIG. 3: (color online) STM images and Raman spectra reveal improved crystalline quality of the p-doped Au-intercalated graphene: panel a) shows topographic STM images for the conventional graphene monolayer (left) and the p-doped graphene monolayer intercalated with Au (right). The images for the conventional monolayer and p-doped monolayer were recorded at a tunneling current of 0.2 nA and a bias of -0.5 V and -0.4 V, respectively. Panel b) compares the Raman scattering results for the conventional (red) and the p-doped (blue) graphene monolayer.

shows a honeycomb lattice with a $(6\sqrt{3} \times 6\sqrt{3})$R30° modulation imposed by the ZL. The graphene lattice of the pML_{Au} is well ordered with single defects (black) and some gold clusters (white). The pML_{Au} shows a superstructure of parallel stripes with a width of about 3 nm as marked by blue arrows in the right panel of Fig. 3 a). This superstructure could be of similar origin as the one reported in [28] despite the fact that the samples in [28] were prepared by depositing Au on a cML. The change of the lattice constant of the superstructure between cML and pML_{Au} is also visible in LEED measurements (see EPAPS).

To further investigate the degree of decoupling of the pML_{Au}, Fig. 3 b) shows Raman scattering data measured for the cML and the pML_{Au}. The substrate contribution to the Raman data was subtracted from the spectra so that the graphene

peaks are clearly visible [29]. The Raman spectrum for the ZL (not shown here) does not show any graphene related features. The 2D peak of the pML_{Au} (blue) appears at 2685 cm^{-1}. It is red-shifted by 50 cm^{-1} as compared to the 2D peak of the cML. As the 2D peak position is only weakly dependent on charge doping [30], we attribute the shift of the 2D peak to an increase of the lattice constant in agreement with the LEED data (see EPAPS). The compressive strain present in the cML is apparently released in the pML_{Au}. This confirms the strongly reduced interactions observed in the analysis of the ARPES linewidth. The data in Fig. 3 b) also suggest that the D:G peak intensity ratio has decreased for the pML_{Au} (blue). The D peak only exists in the presence of defects in the graphene lattice. A reduced D:G peak intensity ratio therefore indicates an improved crystalline quality.

We have shown that it is possible to decouple the graphene ZL formed on the Si-face of SiC from the substrate by Au intercalation. This new slightly p-doped graphene has an improved quality and is only weakly influenced by the underlying substrate. Our ARPES measurements for the pML_{Au} reveal a considerable reduction in linewidth. Our estimation for the carrier lifetime is of the same order of magnitude as the value for multilayer graphene on the C-face of SiC. Therefore, we expect a considerable increase in carrier mobility for the pML_{Au} and correspondingly the transport properties of our pML_{Au} to be closer to those for multilayer graphene on the C-face of SiC.

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EPAPS Available: Details about the sample preparation, the different experimental techniques and the data analysis are available as EPAPS.

EPAPS

Sample preparation

We have grown graphene on the Si-face of SiC. Our 4H SiC wafers were hydrogen-etched before insertion into ultra high vacuum (UHV). To remove residual oxygen impurities we deposited Si from a commercial electron beam evaporator at a substrate temperature of 800°C until a sharp (3×3) low energy electron diffraction (LEED) pattern was observed. We graphitized the samples by direct current heating at elevated temperature. The sample temperature was measured with an optical pyrometer at an emissivity of 63%. An annealing temperature of 1100°C for five minutes is sufficient for the formation of the zero layer (ZL), a pure carbon layer, where every third C-atom forms a chemical bond to a Si-atom in the layer below. This ZL has no graphene properties, in particular, instead of the linear dispersion at the $\overline{\mathrm{K}}$-point of the surface Brillouin zone there are two non-dispersing bands at -0.3 eV and -1.2 eV initial state energy. Upon further annealing at 1150°C for five minutes a purely sp^2-hybridized carbon layer forms on top of the ZL which shows the linear band structure characteristic of massless charge carriers in graphene. This graphene layer is referred to as the conventional monolayer (cML) in the following.

We deposited gold from a commercial Knudsen cell at room temperature on a graphene ZL and annealed the sample at 800°C for five minutes. After this annealing step the linear dispersion characteristic for graphene is clearly visible around the $\overline{\mathrm{K}}$-point of the surface Brillouin zone.

Photoemission experiments

The angle-resolved photoemission spectroscopy (ARPES) measurements in Fig. 1 a) of the manuscript were done with a SPECS HSA 3500 hemispherical analyzer with an energy resolution of 10 meV and monochromatized He II radiation at room temperature. The Fermi surfaces in Fig. 1 b) of the manuscript were measured at the Synchrotron Radiation Center (SRC) in Madison/Wisconsin using a Scienta analyzer with an energy resolution of better than 10 meV, a photon energy of $\hbar\omega = 52$ eV at a sample temperature of 100K. The angular resolution of 0.4° offers a momentum resolution of 0.023 $\mathrm{Å}^{-1}$ at the Fermi level. This is comparable to the offset that was subtracted in Fig. 2 a) of the manuscript for the cML and the $\mathrm{pML_{Au}}$. The Fermi surfaces for the cML and $\mathrm{nML_{Au}}$ were measured with a step size of 0.25° along the $\overline{\Gamma\mathrm{K}}$ direction. As the linewidth for the $\mathrm{pML_{Au}}$ is narrower than for the cML and the $\mathrm{nML_{Au}}$ we had to reduce the stepsize to 0.1° to allow for reasonable data fitting.

The core level spectra in Fig. 2 b) were also measured at the SRC using a photon energy of $\hbar\omega = 150$ eV. They were fitted with Lorentzian peaks including a Shirley background.

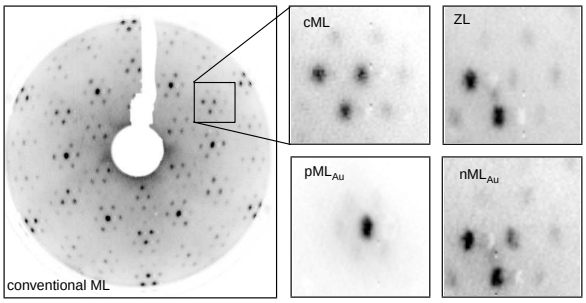

FIG. 4: **LEED images** taken at 126 eV for the conventional graphene monolayer (cML), the zero layer (ZL), the p-doped graphene monolayer ($\mathrm{pML_{Au}}$) and the n-doped graphene monolayer ($\mathrm{nML_{Au}}$). The relative intensity between graphene spot and satellite spots is a measure for the strength of the substrate influence on the graphene layer.

Scanning tunneling experiments

The images in Fig. 3 a) of the manuscript were measured with a room temperature scanning tunneling microscope (STM). The SiC samples with a ZL or cML on top were transferred to the STM chamber in air. Annealing of the samples at 800°C was sufficient to remove any adsorbates from the surface. Au was deposited *in situ* from a commercial electron beam evaporator. The images for the cML and $\mathrm{pML_{Au}}$ were recorded at a tunneling current of 0.2 nA and a bias voltage of -0.5 V and -0.4 V, respectively.

Low energy electron diffraction measurements

Fig. 4 shows LEED images recorded at 126 eV electron energy. This energy is particularly sensitive to the graphene coverage [1]. The image for the cML shows the graphene (10) spot surrounded by satellite peaks from the $(6\sqrt{3}\times6\sqrt{3})$R30° reconstruction. The graphene (10) spot and the two left lower satellite spots have roughly the same intensity. For the ZL there is no graphene spot visible at 126 eV, only the satellite spots are there. The $\mathrm{pML_{Au}}$ has a very bright graphene spot, whereas the satellite peaks are considerably reduced in intensity. Furthermore, the distance between the satellite peaks and the graphene peak is smaller than for the cML indicating a larger lattice constant of the superstructure. This can be related to the strain release in the $\mathrm{pML_{Au}}$ that was revealed in the Raman measurements in Fig. 3 b) of the manuscript. The strain release results in a new commensurate periodicity in agreement with the STM measurements in Fig. 3 a) of the manuscript that show an increase of the superlattice constant by about a factor of two when comparing cML and $\mathrm{pML_{Au}}$. The LEED image for the $\mathrm{nML_{Au}}$ is very similar to that of the cML indicating a similar influence of the underlying substrate in both cases.

Raman measurements

The Raman spectra shown in the manuscript were measured under ambient conditions using an Argon ion laser with a wavelength of 488 nm. The laser spot size was 400 nm in diameter and the laser power was 4 mW. The measured graphene signal is rather weak and superposed by the signal from the SiC substrate. For the Raman data shown in Fig. 3 b) of the manuscript we subtracted the substrate contribution so that the graphene peaks become clearly visible [2].

The Raman spectra are characterized by three main graphene contributions: The G peak corresponds to an in-plane vibration of the two sublattices with respect to each other. The D and 2D peak come from a double resonance scattering process [3]. The 2D peak is always visible, whereas the D peak only appears in the presence of defects. Both G and 2D peaks shift as a function of doping [4-6] and strain [7,8]. Therefore, it is difficult to determine charge carrier concentration and strain directly from the Raman data. However, the doping induced shift is strongest for the G peak [5,6], whereas the effect of strain is more pronounced for the 2D peak [7]. If the effect of the charge carrier concentration can be determined by another procedure (in this case ARPES data), the Raman data provide useful information about strain.

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